

Vishay Siliconix

RoHS

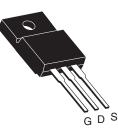
COMPLIANT

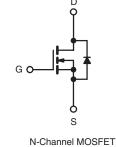


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	400			
R _{DS(on)} (Ω)	V _{GS} = 10 V	1.8		
Q _g (Max.) (nC)	20			
Q _{gs} (nC)	3.3			
Q _{gd} (nC)	11			
Configuration	Single			

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI720GPbF
	SiHFI720G-E3
SnPb	IRFI720G
	SiHFI720G

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	400	V		
Gate-Source Voltage			V _{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	1_	2.6		
	V_{GS} at 10 V $T_C = 100$	$T_C = 100 ^{\circ}C$	I _D	1.7	А	
Pulsed Drain Current ^a			I _{DM}	10		
Linear Derating Factor				0.24	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	150	mJ	
Repetitive Avalanche Current ^a			I _{AR}	2.6	A	
Repetitive Avalanche Energy ^a			E _{AR}	3.0	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D 30		W	
Peak Diode Recovery dV/dtc			dV/dt	4.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	C	
Mounting Torque	6 22 or 1	6-32 or M3 screw		10	lbf ⋅ in	
	0-02 OF WIG SCIEW		-	1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 38 mH, $R_G = 25 \Omega$, $I_{AS} = 2.6$ A (see fig. 12).

c. $I_{SD} \le 3.3$ A, dI/dt ≤ 65 A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

Vishay Siliconix



PARAMETER	SYMBOL	TYP		MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65 - 4.1			• °C/W					
Maximum Junction-to-Case (Drain)	R _{thJC}									
	. 1100									
SPECIFICATIONS T _J = 25 °C, u	unless otherv	vise noted								
PARAMETER	SYMBOL		T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT		
Static						I	I			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 µA	400	-	-	V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	e to 25 °C,	I _D = 1 mA	-	0.51	-	V/°C		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 2	250 μΑ	2.0	-	4.0	V		
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 V$			-	-	± 100	nA		
7		V _{DS} = 400 V, V _{GS} = 0 V		s = 0 V	-	-	25	1.		
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 320 V	′, V _{GS} = 0 V	, T _J = 125 °C	-	-	250	μA		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 1.6 A ^b	-	-	1.8	Ω		
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	1.6 A ^b	1.5	-	-	S		
Dynamic						•	•			
Input Capacitance	Ciss	V _{GS} = 0 V,		-	410	-				
Output Capacitance	C _{oss}		$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		-	120	-			
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	47	-	pF			
Drain to Sink Capacitance	С			-	12	-				
Total Gate Charge	Qg				-	-	20			
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		3 A, V _{DS} = 320 V, e fig. 6 and 13 ^b	-	-	3.3	nC		
Gate-Drain Charge	Q _{gd}		see lig. 6 ar		-	-	11	1		
Turn-On Delay Time	t _{d(on)}				-	10	-			
Rise Time	tr		200 V, I _D =		-	14	-	1		
Turn-Off Delay Time	t _{d(off)}	R _G = 18 Ω, R _D = 56 Ω, see fig. 10 ^b		-	30	-	ns			
Fall Time	t _f		Ū		-	13	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-				
Internal Source Inductance	L _S			-	7.5	-	nH			
Drain-Source Body Diode Characteristic	s	•								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.6	A			
Pulsed Diode Forward Current ^a	I _{SM}			-	-	10				
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 2.6 \ A, \ V_{GS} = 0 \ V^b$		-	-	1.6	V			
Body Diode Reverse Recovery Time	t _{rr}	T 05 °C I	- 224 41	dt - 100 A/uch	-	300	600	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = 3.3 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^{b}$		-	1.5	3.0	μC			
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time i	s negligible (turn	on is dor	ninated by	v Ls and I	LD)		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



Vishay Siliconix



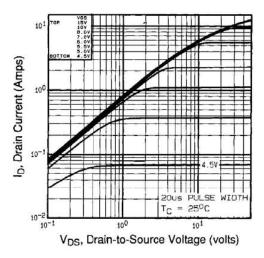


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

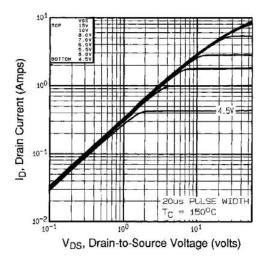


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

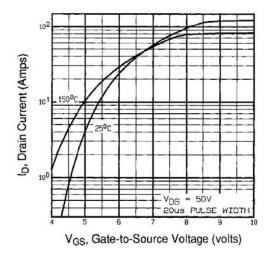


Fig. 3 - Typical Transfer Characteristics

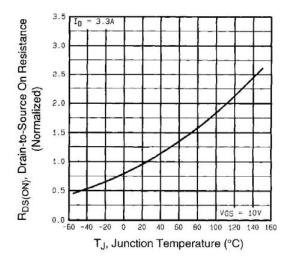


Fig. 4 - Normalized On-Resistance vs. Temperature

Vishay Siliconix



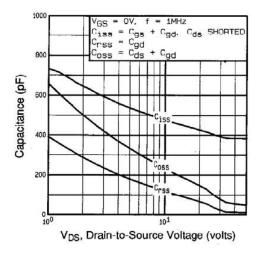


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

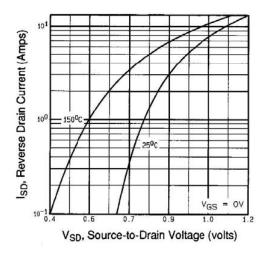


Fig. 7 - Typical Source-Drain Diode Forward Voltage

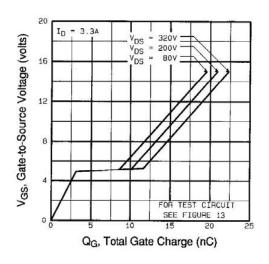


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

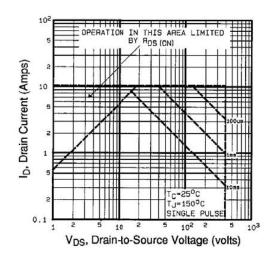


Fig. 8 - Maximum Safe Operating Area



Vishay Siliconix

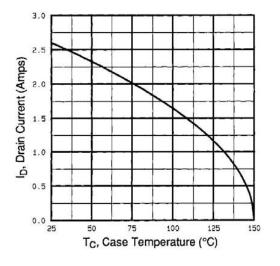


Fig. 9 - Maximum Drain Current vs. Case Temperature

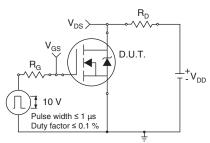


Fig. 10a - Switching Time Test Circuit

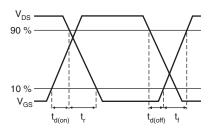
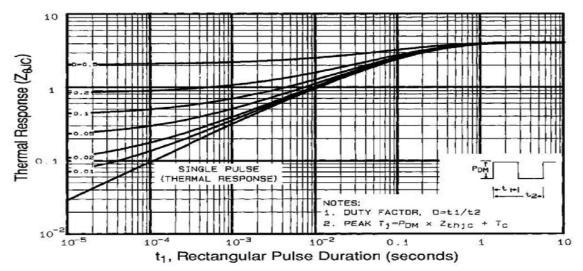
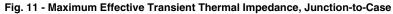


Fig. 10b - Switching Time Waveforms





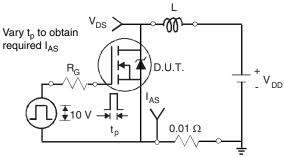


Fig. 12a - Unclamped Inductive Test Circuit

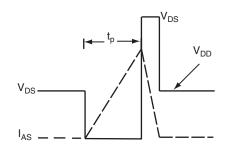


Fig. 12b - Unclamped Inductive Waveforms

Vishay Siliconix



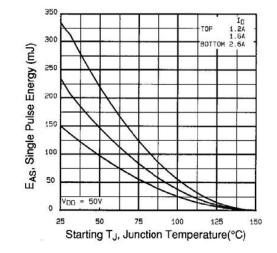


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

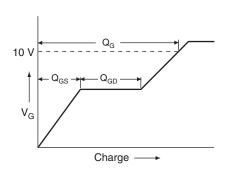
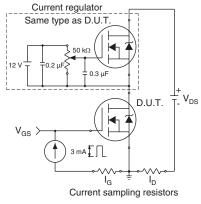


Fig. 13a - Basic Gate Charge Waveform

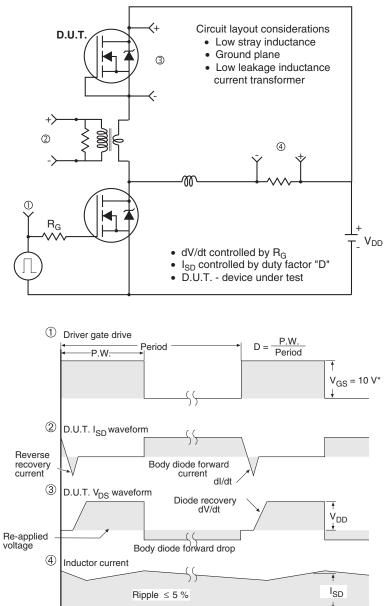






Vishay Siliconix





Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91152.



Vishay

Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.